

(12) United States Design Patent (10) Patent No.: US D476,245 S Jun. 24, 2003 Tanaka et al. (45) **Date of Patent:** **

INSULATION RESISTANCE TESTER (54)

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- 14 Years (**) Term:
- Appl. No.: 29/160,873 (21)

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(57)**CLAIM**

The ornamental design for an insulation resistance tester, as shown and described.

DESCRIPTION

FIG. 1 is a perspective view of an insulation resistance tester

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- LOC (7) Cl. 10-04 (51)
- **U.S. Cl.** **D10/75**; D10/78 (52)
- Field of Search D10/46, 75, 78; (58)324/502, 705, 707, 712, 713, 722, 514, 551; 200/61.64; 340/640, 658

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showing our new design; FIG. 2 is a front view thereof; FIG. 3 is a rear view thereof; FIG. 4 is a top plan view thereof; FIG. 5 is a bottom view thereof; FIG. 6 is a left side view thereof; FIG. 7 is a right side view thereof; FIG. 8 is a left side view with the front cover thereof being opened;

FIG. 9 is a front view with the front cover thereof being opened and all the display elements on the panel being on; and,

FIG. 10 is a perspective view showing the tester with its cover opened and probes, shown in phantom line, accommodated in the tester.

1 Claim, 6 Drawing Sheets



U.S. Patent US D476,245 S Jun. 24, 2003 Sheet 1 of 6



U.S. Patent Jun. 24, 2003 Sheet 2 of 6 US D476,245 S





FIG. 3



U.S. Patent Jun. 24, 2003 Sheet 3 of 6 US D476,245 S

FIG. 4







U.S. Patent Jun. 24, 2003 Sheet 4 of 6 US D476,245 S



FIG. 6





U.S. Patent Jun. 24, 2003 Sheet 5 of 6 US D476,245 S





U.S. Patent Jun. 24, 2003 Sheet 6 of 6 US D476,245 S

FIG. 9



